

Description

The PSMN4R3-30BL uses advanced trench technology

to provide excellent $R_{\text{DS}(\text{ON})},$ low gate charge and

operation with gate voltages as low as 4.5V. This

device is suitable for use as a

Battery protection or in other Switching application.

General Features

V_{DS} = 30V I_D =100 A

 $R_{DS(ON)} < 5m\Omega @ V_{GS}=10V$

Application

Battery protection

Load switch Uninterruptible power supply

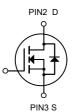
Package Marking and Ordering Information

Product ID	Pack	Brand	Qty(PCS)
PSMN4R3-30BL	TO-252-2L	HXY MOSFET	2500

Absolute Maximum Ratings (Tc=25°C unless otherwise noted)

Symbol	Parameter	Rating	Units
VDS	Drain- Source Voltage	30	V
VGS	Gate-Source Voltage	±20	V
I _D @T _C =25℃	Continuous Drain Current, V _{GS} @ 10V ¹	100	А
I _D @Tc=100°C	Continuous Drain Current, V _{GS} @ 10V ¹	57	А
Ідм	Pulsed Drain Current ²	160	А
EAS	Single Pulse Avalanche Energy ³	115.2	mJ
las	Avalanche Current	48	А
P₀@Tc=25°C	Total Power Dissipation ⁴	53	W
Тятс	Storage Temperature Range	-55 to 175	°C
TJ	Operating Junction Temperature Range	-55 to 175	°C
R ₀ JA	Thermal Resistance Junction-ambient (Steady State) ¹	62	°C/W
Reja	Thermal Resistance Junction-Ambient ¹ (t ≤10s)	25	°C/W
R _θ JC	Thermal Resistance Junction-Case ¹	2.8	°C/W





N-Channel MOSFET

Electrical Characteristics (T_J=25°C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	30			V
∆BVbss/∆Tj	BVDSS Temperature Coefficient	Reference to 25°C, I₀=1mA		0.028		V/°C
.Rds(on)		V _{GS} =10V , I _D =30A		3.8	5.5	
.105(0N)	Static Drain-Source On- Resistance ²	V _{GS} =4.5V , I _D =15A		7.5	9	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} , I _D =250uA	1.0	1.5	2.5	V
$\Delta V_{GS(th)}$	V _{GS(th)} Temperature Coefficient			-6.16		mV/°C
IDSS	Drain Source Leekage Current	V _{DS} =24V , V _{GS} =0V , T _J =25°C			1	
IDSS	Drain-Source Leakage Current	V _{DS} =24V , V _{GS} =0V , TJ=55°C			5	uA
lgss	Gate-Source Leakage Current	V_{GS} = $\pm20V$, V_{DS} = $0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =30A		22		S
Rg	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7	3.4	Ω
Qg	Total Gate Charge (4.5V)			20		nC
Qgs	Gate-Source Charge	V _{DS} =15V , V _{GS} =4.5V , I _D =15A		7.6		
Q _{gd}	Gate-Drain Charge	10-13A		7.2		
Td(on)	Turn-On Delay Time			7.8		ns
Tr	Rise Time	V _{DD} =15V , V _{GS} =10V ,		15		
Td(off)	Turn-Off Delay Time	-R _G =3.3		37.3		
T _f	Fall Time	_I _D =15A		10.6		
C _{iss}	Input Capacitance			2295		
Coss	Output Capacitance	V _{DS} =15V , V _{GS} =0V ,		267		pF
Crss	Reverse Transfer Capacitance	_f=1MHz		210		
Is	Continuous Source Current ^{1,5}	V _G =V _D =0V , Force			80	Α
Ism	Pulsed Source Current ^{2,5}	Current			160	А
Vsd	Diode Forward Voltage ²	V _{GS} =0V , Is=1A , TJ=25°C			1	V
trr	Reverse Recovery Time	IF=30A , dl/dt=100A/µs ,		14		nS
Qrr	Reverse Recovery Charge	TJ=25°C		5		nC

Note :

1. The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper.

2. The data tested by pulsed , pulse width . The EAS data shows $\ensuremath{\mathsf{Max}}\xspace$. rating .

3.The test cond \leq 300us , duty cycle ition is V_DD=25 \leq V,V 2%GS =10V,L=0.1mH,I_AS=53.8A

4.The power dissipation is limited by 175°C junction temperature

5.The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.



PSMN4R3-30BL N-Channel Enhancement Mode MOSFET

Typical Characteristics

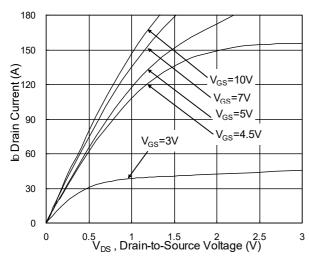


Fig.1 Typical Output Characteristics

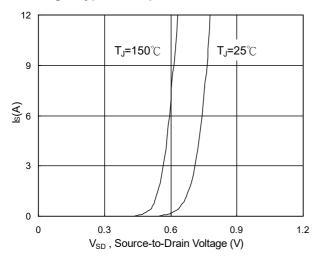


Fig.3 Forward Characteristics of Reverse

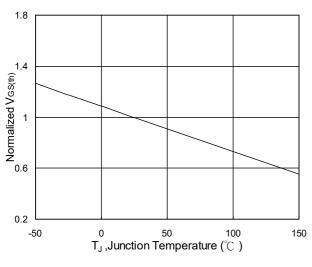


Fig.5 Normalized $V_{\text{GS(th)}}\, vs.\, T_{\text{J}}$

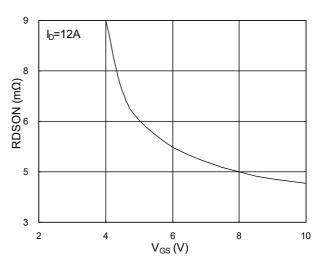


Fig.2 On-Resistance vs. G-S Voltage

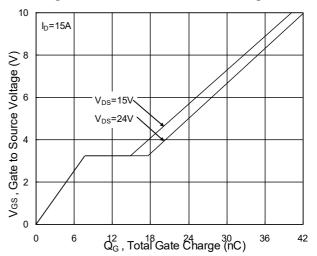


Fig.4 Gate-Charge Characteristics

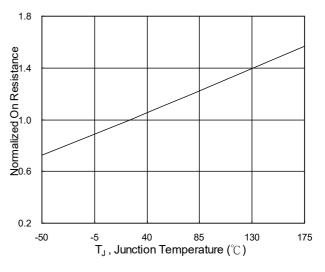
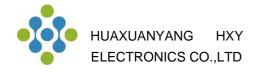


Fig.6 Normalized R_{DSON} vs. T_{J}



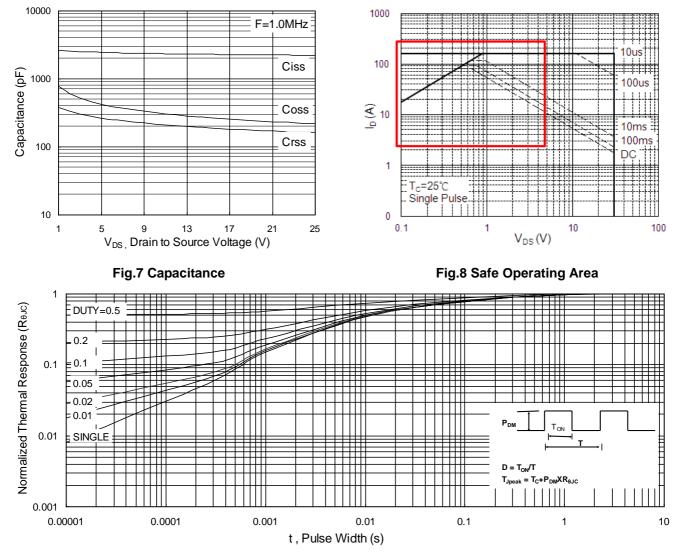


Fig.9 Normalized Maximum Transient Thermal Impedance

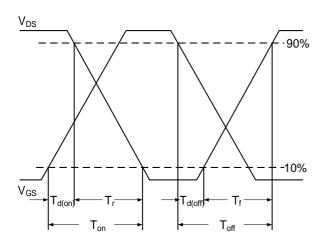


Fig.10 Switching Time Waveform

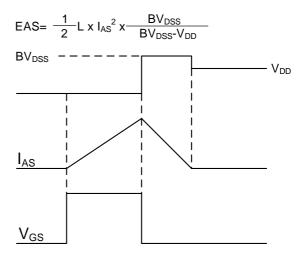
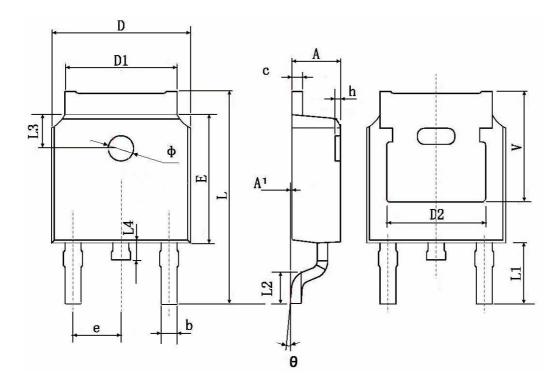


Fig.11 Unclamped Inductive Switching Waveform



TO-252-2L Package Information



Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min.	Max.	Min.	Max.	
A	2.200	2.400	0.087	0.094	
A1	0.000	0.127	0.000	0.005	
b	0.660	0.860	0.026	0.034	
с	0.460	0.580	0.018	0.023	
D	6.500	6.700	0.256	0.264	
D1	5.100	5.460	0.201	0.215	
D2	0.483 TYP.		0.190 TYP.		
E	6.000	6.200	0.236	0.244	
е	2.186	2.386	0.086	0.094	
L	9.800	10.400	0.386	0.409	
L1	2.900 TYP.		0.114 TYP.		
L2	1.400	1.700	0.055	0.067	
L3	1.600 TYP.		0.063 TYP.		
L4	0.600	1.000	0.024	0.039	
Φ	1.100	1.300	0.043	0.051	
θ	0°	8°	0°	8°	
h	0.000	0.300	0.000	0.012	
V	5.350 TYP. 0.211 TYP.		1 TYP.		



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